

N-Channel Silicon Carbide MOSFET Module

Rev.02 - 01 March 2025

Product data sheet

alogen-Free

ead-Free

1. General description

WeEnPACK-B1 module with WeEn 1200V Gen2 SiC MOSFET and Press-fit pin type. NTC temperature sensor inside.

2. Features and benefits

- 3-phase full bridge topology
- Press-fit pin configuration
- Low ON resistance
- Low switching losses
- Reduced Q_g and C_{rss}
- Minimized circuit impedance
- Robust product design

3. Applications

- EV chargers
- Energy storage and solar energy systems
- Power Inverters
- AC/DC converters
- Power factor correctors
- Motor drives

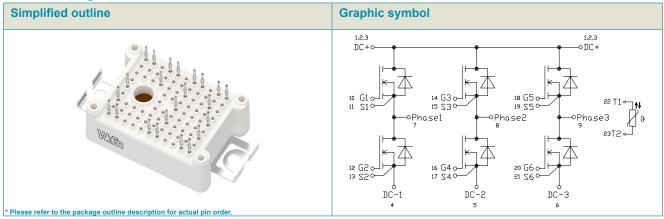
4. Quick reference data

| Table 1. Q | uick reference data | | | | | | |
|---------------------|------------------------------|---|-------|------------|------|-----|------|
| Symbol | Parameter | Conditions | Notes | Values | | | Unit |
| Absolute | maximum rating | | | | | | |
| V _{DS} | drain-source voltage | T _j = 25 °C | | | 1200 | | V |
| I _D | drain current | V _{GS} = 18 V; T _h = 25 °C | | | 59 | | А |
| P _{tot} | total power dissipation | T _h = 25 °C | | | 91 | | W |
| $T_{j.op}$ | maximum junction temperature | | | -40 to 150 | | °C | |
| Symbol | Parameter | Conditions | Notes | Min | Тур | Max | Unit |
| Static ch | aracteristics | | | | · | | |
| $R_{\text{DS(on)}}$ | drain-source on-state | V _{GS} = 15 V; I _D = 50 A; T _j = 25 °C | | - | 20 | - | mΩ |
| | resistance | V _{GS} = 18 V; I _D = 50 A; T _j = 25 °C | | - | 16.3 | 29 | mΩ |
| Dynamic | characteristics | | 1 | | | | |
| Q _{G(tot)} | total gate charge | $I_{D} = 50 \text{ A}; V_{DS} = 800 \text{ V}; V_{GS} = -4 \text{ V}/18 \text{ V};$ | | - | 215 | - | nC |
| Q _{GD} | gate-drain charge | T _j = 25 °C | | - | 32 | - | nC |
| Source-d | Irain diode | | | | | | |
| Q _r | recovered charge | $ \begin{array}{ c c c c c c c c c c c c c c c c c c c$ | | - | 1072 | - | nC |

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5. Pinning information





6. Ordering information

| Table 3. Ordering information | | | | | | | | |
|-------------------------------|-----------------|-----------------------|----------------|---------------------------|----------------------|-----------------------|--|--|
| Type number | Package Name | Orderable part number | Packing method | Small packing quantity | Package version | Package issue date | | |
| WMSC020S12B1P | WeEnPACK-B1 | WMSC020S12B1P6T | Tray | | WeEnPACK- B1PSB-B | 13-Jun-2024 | | |

7. Marking

| Table 4. Marking codes | | | | | | | | |
|------------------------|---------------|---------------|--|--|--|--|--|--|
| | Type number | Marking codes | | | | | | |
| | WMSC020S12B1P | WMSC020S12B1P | | | | | | |

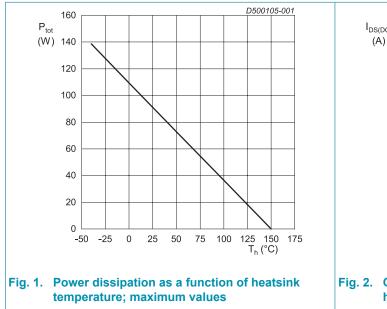
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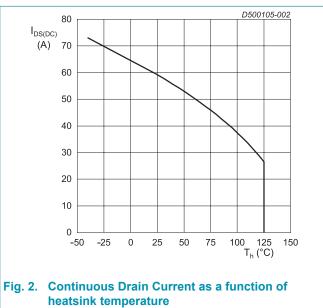
8. Limiting values

Table 5. Limiting values

In accordance with the Absolute Maximum Rating System (IEC 60134).

| Symbol | Parameter | Conditions | Notes | Values | Unit |
|-----------------------|--|---|-------|------------|------|
| T _{stg} | storage temperature | | | -40 to 125 | °C |
| T _{j.op} | operating junction temperature | | | -40 to 150 | °C |
| T _{j.max} | maximum junction temperature | Intermittent condition with shortened lifetime | | -40 to 175 | °C |
| V _{ISOL} | RMS isolation voltage | T _j = 25 °C; all terminals shorted; f = 50 Hz; t = 1 s | | 3500 | V |
| MOSFET | - | | | | |
| V _{DS} | drain-source voltage | T _j = 25 °C | | 1200 | V |
| V _{GS,max} | gate-source voltage | Absolute maximum values | | -12 to 24 | V |
| $V_{GS,op}$ | gate-source voltage | Recommended operational values | | -4 to 18 | V |
| P _{tot} | total power dissipation | T _h = 25 °C | | 91 | W |
| I _D | drain current | V _{GS} = 18 V; T _h = 25 °C | | 59 | А |
| | | V _{GS} = 18 V; T _h = 100 °C | | 37 | А |
| I _{DM} | peak drain current | pulse width t_p limited by T_{jmax} | | 118 | А |
| E _{as} | single pulse drain-to- source avalanche | I_{AS} = 30 A; L = 1 mH; V _{DD} = 100 V; T _{j(init)} = 25 °C; per MOSFET | | 450 | mJ |
| Body Diod | de | | | | |
| I _{SD} | DC body diode forward current | V _{GS} = -4 V; T _h = 25 °C | | 30 | А |
| I _{SD,pulse} | Pulse body diode current | verified by design, t_p limited by T_{jmax} | | 118 | А |



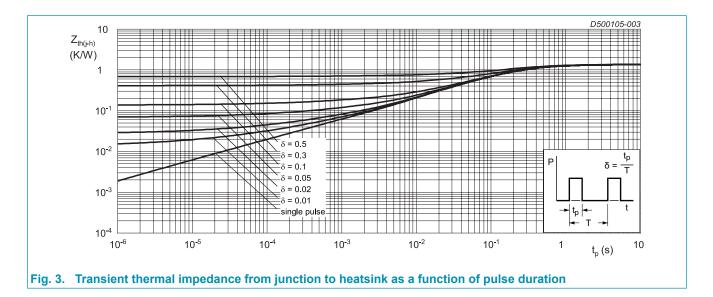


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9. Thermal characteristics

| Symbol | Parameter | Conditions | Notes | Min | Тур | Max | Unit |
|--------------------|--|---|-------|--------------------------------|------|-----|------|
| $R_{th(j-c)}$ | thermal resistance from junction to case | per MOSFET | | - | 0.59 | - | K/W |
| $R_{th(j-h)}$ | thermal resistance from junction to heatsink | per MOSFET, $\lambda_{grease} = 1 \text{ W/(m·K)}$, thick _{grease} = 50 um | | - | 1.37 | - | K/W |
| Internal Isolation | | basic insulation (class 1, IEC 61140) | | Al ₂ O ₃ | | | |
| d _{Creep} | Creepage distance | terminal to heatsink | | - | 11.5 | - | mm |
| | | terminal to terminal | | - | 6.3 | - | mm |
| d _{Clear} | Clearance | terminal to heatsink | | - | 10 | - | mm |
| | | terminal to terminal | | - | 5 | - | mm |
| СТІ | Comperative tracking index | | | | >200 | _ | |
| F | Mounting force per clamp | | | 20 | - | 50 | Ν |
| G | Approximate Weight | | | - | 20 | - | g |

Note: Module is ESD sensitive. Handling precautions are recommended.



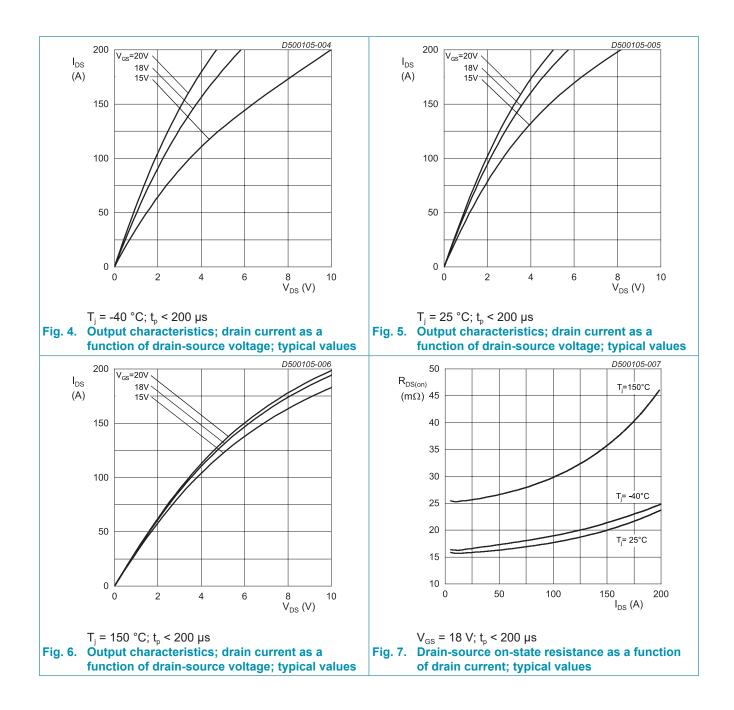
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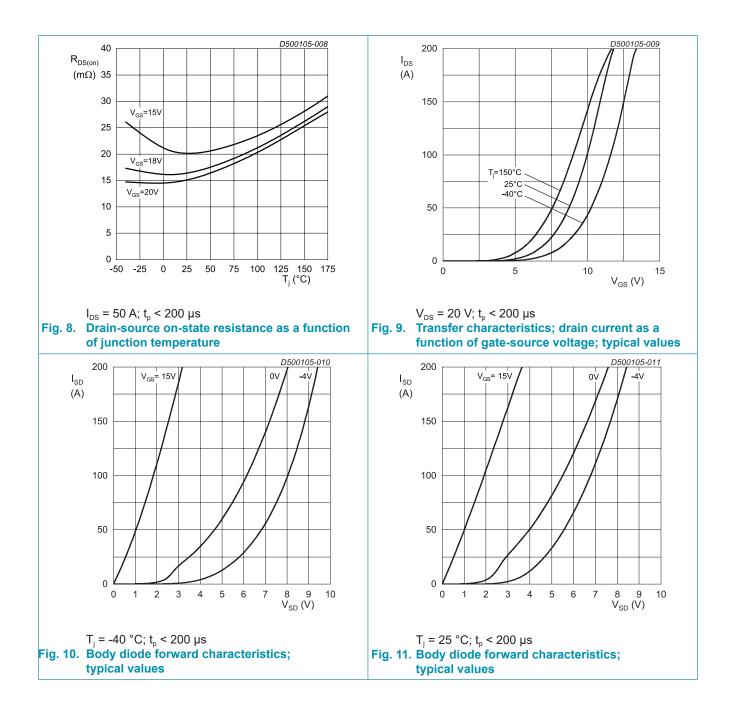
10. Characteristics

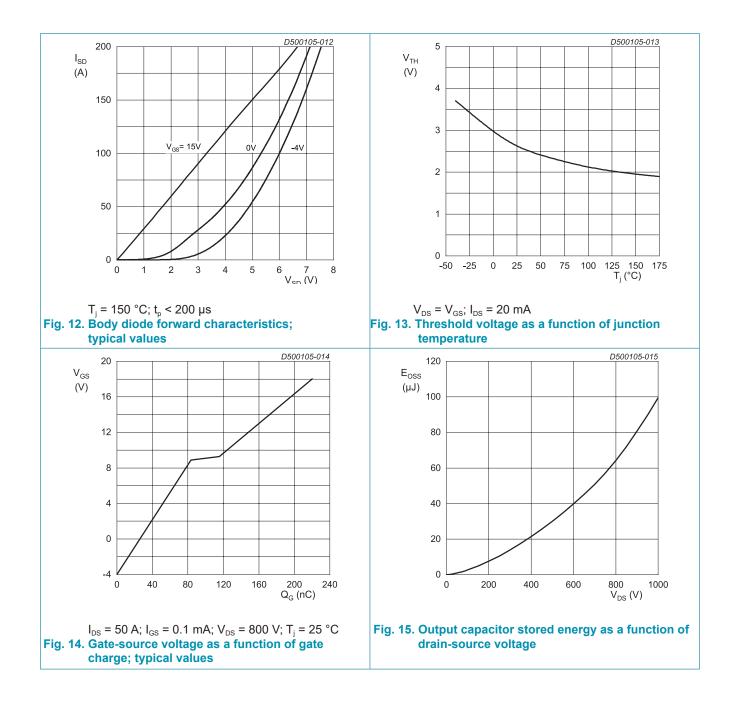
Table 7. Characteristics

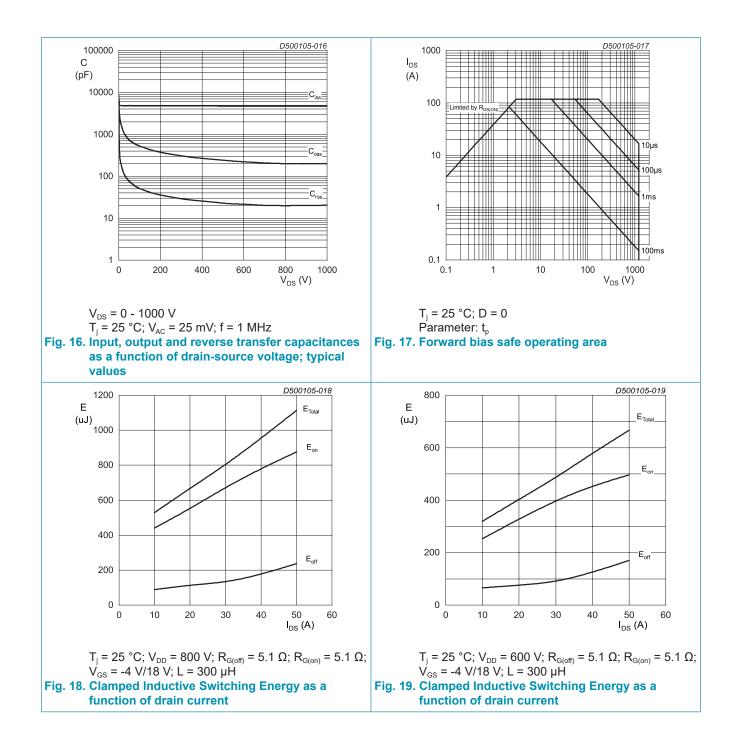
| MOSFET | | | | | | | |
|---------------------|--------------------------------|---|-------|------|------|-----|------|
| Symbol | Parameter | Conditions | Notes | Min | Тур | Max | Unit |
| Static ch | aracteristics | | | | | | |
| $V_{(BR)DSS}$ | drain-source breakdown voltage | I_{D} = 100 µA; V_{GS} = 0 V; T_{j} = 25 °C | | 1200 | - | - | V |
| V _{GS(th)} | gate-source threshold | I_{D} = 20 mA; V_{DS} = V_{GS} ; T_{j} = 25 °C | | 1.9 | 2.6 | 3.5 | V |
| | voltage | I_{D} = 20 mA; V_{DS} = V_{GS} ; T_{j} = 175 °C | | - | 1.9 | - | V |
| I _{DSS} | drain leakage current | V_{DS} = 1200 V; V_{GS} = 0 V; T_j = 25 °C | | - | 0.2 | 100 | μA |
| I _{GSS} | gate leakage current | V _{GS} = 24 V; V _{DS} = 0 V; T _j = 25 °C | | - | 10 | 100 | nA |
| | (absolute value) | V _{GS} = -12 V; V _{DS} = 0 V; T _j = 25 °C | | - | 10 | 100 | nA |
| $R_{\text{DS(on)}}$ | drain-source on-state | V _{GS} = 15 V; I _D = 50 A; T _j = 25 °C | | - | 20 | - | mΩ |
| | resistance | V _{GS} = 18 V; I _D = 50 A; T _j = 25 °C | | - | 16.3 | 29 | mΩ |
| | | V _{GS} = 18 V; I _D = 50 A; T _j = 125 °C | | - | 24 | - | mΩ |
| | | V _{GS} = 18 V; I _D = 50 A; T _j = 150 °C | | - | 26 | - | mΩ |
| | | V _{GS} = 18 V; I _D = 50 A; T _j = 175 °C | | - | 27.3 | - | mΩ |
| R _G | gate resistance | f = 1 MHz; T_j = 25 °C; per MOSFET | | - | 0.6 | - | Ω |
| g _{fs} | transconductance | V _{DS} = 20 V; I _D = 50 A; T _j = 25 °C | | - | 32 | - | S |
| Dynamic | characteristics | · | | | | | |
| Q _{G(tot)} | total gate charge | $I_{D} = 50 \text{ A}; V_{DS} = 800 \text{ V}; V_{GS} = -4 \text{ V}/18 \text{ V};$ | | - | 215 | - | nC |
| Q _{GS} | gate-source charge | T _j = 25 °C | | - | 83 | - | nC |
| Q_{GD} | gate-drain charge | - | | - | 32 | - | nC |
| C _{iss} | input capacitance | $V_{DS} = 1000 V; V_{GS} = 0 V; f = 1 MHz;$ | | - | 4701 | - | pF |
| C _{oss} | output capacitance | T _j = 25 °C | | - | 199 | - | pF |
| C _{rss} | reverse transfer capacitance | | | - | 20 | - | pF |
| E _{oss} | Coss stored energy | | | - | 100 | - | μJ |
| t _{d(on)} | turn-on delay time | $V_{DS} = 800 \text{ V}; V_{GS} = -4 \text{ V}/18 \text{ V};$ | | - | 23 | - | ns |
| t _r | rise time | $R_{G(off)} = 5.1 \Omega; R_{G(on)} = 5.1 \Omega;$ I _D = 50 A; L = 300 μH; T _i = 25 °C | | - | 16 | - | ns |
| t _{d(off)} | turn-off delay time | | | - | 64 | - | ns |
| t _f | fall time | | | - | 19 | - | ns |
| Eon | turn-on energy | | | - | 877 | - | μJ |
| E _{off} | turn-off energy | | | - | 237 | - | μJ |

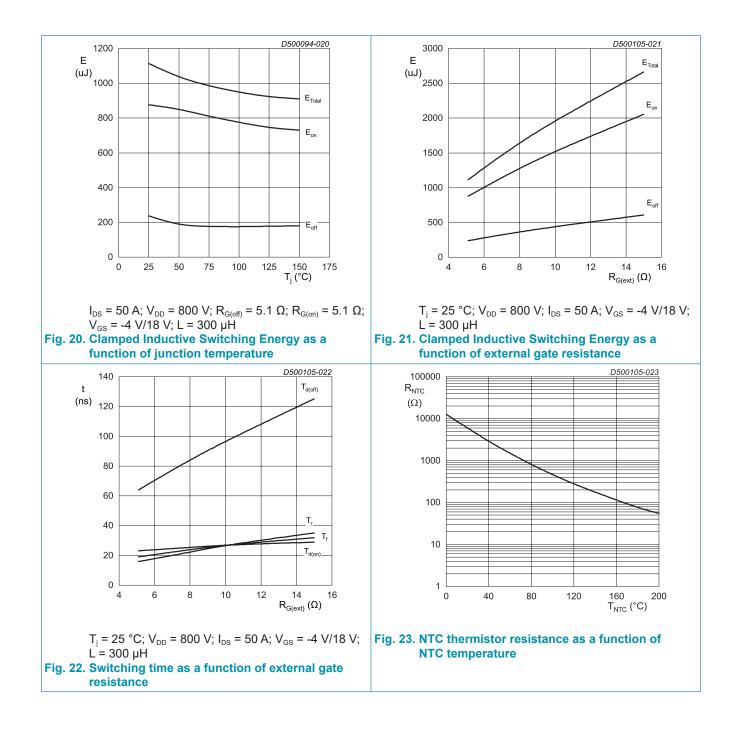
| Body did | ode | | | | | | |
|--------------------|-------------------------------|--|-------|--------|------|-----|------|
| Symbol | Parameter | Conditions | Notes | Min | Тур | Max | Unit |
| Static ch | aracteristics | | | | | | |
| V_{SD} | source-drain voltage | V_{GS} = -4 V; I_{SD} = 50 A; T_j = 25 °C | | - | 5.5 | - | V |
| | | V_{GS} = -4 V; I_{SD} = 50 A; T_j = 150 °C | | - | 5.0 | - | V |
| Dynamic | characteristics | | | | | | |
| I _{rrm} | reverse recovery current | | | - | 67 | - | А |
| t _{rr} | reverse recovery time | di/dt = 2300 A/μs; R _{G(ext)} = 5.1 Ω; T _i = 25 °C | | - | 27 | - | ns |
| Q _r | recovered charge | ., | | - | 1072 | - | nC |
| E _{rec} | reverse recovery energy | | | - | 178 | - | μJ |
| I _{rrm} | reverse recovery current | I_{SD} = 50 A; V_{GS} = -4 V/18 V; V_{R} = 600 V; | | - | 74 | - | А |
| t _{rr} | reverse recovery time | di/dt = 3000 A/μs; R _{G(ext)} = 5.1 Ω; T _i = 150 °C | | - | 29 | - | ns |
| Q _r | recovered charge | | | - | 1368 | - | nC |
| E _{rec} | reverse recovery energy | | | - | 207 | - | μJ |
| NTC ther | mistor | | | | | | |
| Symbol | Parameter | Conditions | Notes | Min | Тур | Max | Unit |
| R ₂₅ | Rated resistance | T _{NTC} = 25 °C | | - | 5000 | - | Ω |
| R ₁₀₀ | | T _{NTC} = 100 °C | | 465±5% | | Ω | |
| B _{25/50} | B-value | $R_2 = R_{25} \exp[B_{25/50}(1/T_2 - 1/(298.15K))]$ | | 3380 | | К | |
| | Maximum operating temperature | | | - | 200 | - | °C |
| | Dissipation costant | | | - | 2 | - | mW/K |
| | Thermal time constant | | | - | ≤10 | - | s |





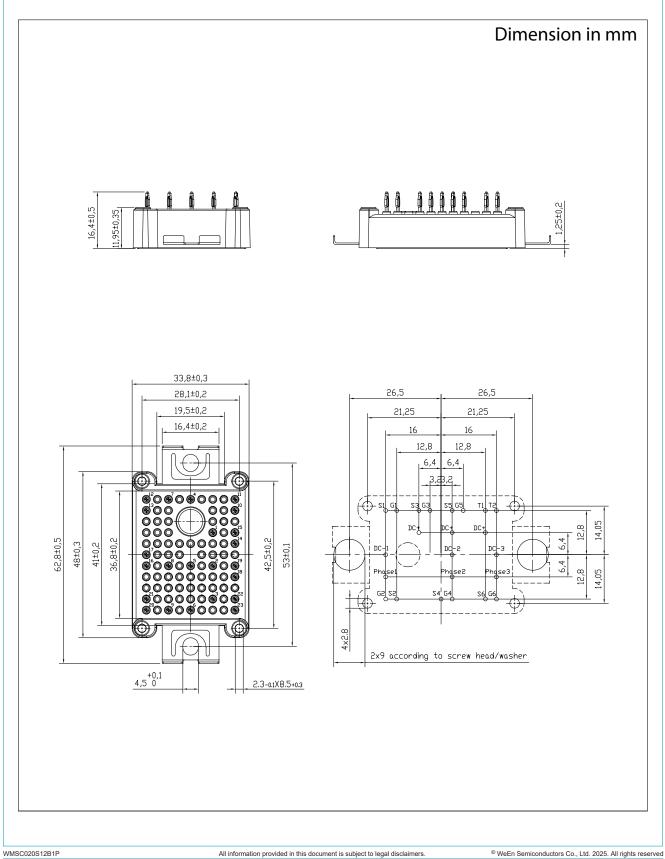






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11. Package outline



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12. Legal information

Data sheet status

| Document status [1][2] | Product status [3] | Definition |
|--------------------------------------|-----------------------|---|
| Objective [short] data sheet | Development | This document contains data from the objective specification for product development. |
| Preliminary [short] data sheet | Qualification | This document contains data from the preliminary specification. |
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- [2] The term 'short data sheet' is explained in section "Definitions".
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